

**Notice of References Cited**

Application/Control No.

10/506,427

Applicant(s)/Patent Under

Reexamination

TANAKA ET AL.

Examiner

CAROLINE ARCOS

Art Unit

2195

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,179,702 A	01-1993	Spix et al.	718/102
*	B US-5,361,362 A	11-1994	Benkeser et al.	718/102
*	C US-5,752,030 A	05-1998	Konno et al.	718/102
*	D US-2002/0004814 A1	01-2002	Tanaka, Katsuyoshi	709/201
*	E US-6,338,055 B1	01-2002	Hagmann et al.	707/2
*	F US-2002/0198924 A1	12-2002	Akashi et al.	709/102
*	G US-2002/0198923 A1	12-2002	Hayes, Kent F. JR.	709/102
*	H US-2003/0074387 A1	04-2003	Tanaka, Katsuyoshi	709/103
*	I US-6,578,064 B1	06-2003	Saito et al.	718/103
*	J US-2004/0205108 A1	10-2004	Tanaka, Katsuyoshi	709/201
*	K US-2006/0235732 A1	10-2006	Miller et al.	705/007
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	English translation of JP 07-244653
V	English translation of JP 2001-318776
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.